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With the principle of “Quality Parts,Customers Priority,Honest Operation,and Considerate Service”,our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip,ALPS,ROHM,Xilinx,Pulse,ON,Everlight and Freescale. Main products comprise IC,Modules,Potentiometer,IC Socket,Relay,Connector.Our parts cover such applications as commercial,industrial, and automotives areas.

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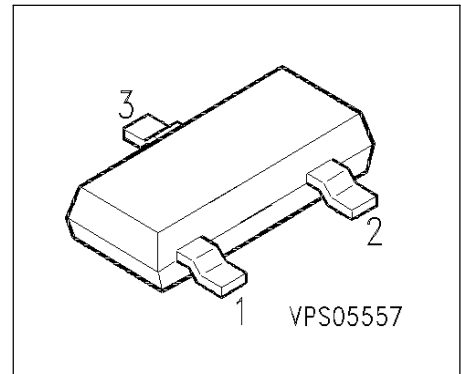
Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China



## BSS 123

### SIPMOS® Small-Signal Transistor

- N channel
- Enhancement mode
- Logic Level
- $V_{GS(th)} = 0.8...2.0V$



|       |       |       |
|-------|-------|-------|
| Pin 1 | Pin 2 | Pin 3 |
| G     | S     | D     |

| Type    | $V_{DS}$ | $I_D$  | $R_{DS(on)}$ | Package | Marking |
|---------|----------|--------|--------------|---------|---------|
| BSS 123 | 100 V    | 0.17 A | 6 $\Omega$   | SOT-23  | SAs     |

| Type    | Ordering Code | Tape and Reel Information |
|---------|---------------|---------------------------|
| BSS 123 | Q62702-S512   | E6327                     |
| BSS 123 | Q67000-S245   | E6433                     |

### Maximum Ratings

| Parameter                                | Symbol      | Values   | Unit |
|--|-------------|----------|------|
| Drain source voltage                     | $V_{DS}$    | 100      | V    |
| Drain-gate voltage                       | $V_{DGR}$   | 100      |      |
| $R_{GS} = 20 \text{ k}\Omega$            |             |          |      |
| Gate source voltage                      | $V_{GS}$    | $\pm 20$ |      |
| ESD Sensitivity (HBM) as per MIL-STD 883 |             | Class 1  |      |
| Continuous drain current                 | $I_D$       | 0.17     | A    |
| $T_A = 28 \text{ }^\circ\text{C}$        |             |          |      |
| DC drain current, pulsed                 | $I_{Dpuls}$ | 0.68     |      |
| $T_A = 25 \text{ }^\circ\text{C}$        |             |          |      |
| Power dissipation                        | $P_{tot}$   | 0.36     | W    |
| $T_A = 25 \text{ }^\circ\text{C}$        |             |          |      |

**Maximum Ratings**

| Parameter  | Symbol      | Values        | Unit |
|--|-------------|---------------|------|
| Chip or operating temperature                                  | $T_j$       | -55 ... + 150 | °C   |
| Storage temperature  | $T_{stg}$   | -55 ... + 150 |      |
| Thermal resistance, chip to ambient air <sup>1)</sup>          | $R_{thJA}$  | ≤ 350         | K/W  |
| Thermal resistance, chip-substrate- reverse side <sup>1)</sup> | $R_{thJSR}$ | ≤ 285         |      |
| DIN humidity category, DIN 40 040                              |             | E             |      |
| IEC climatic category, DIN IEC 68-1                            |             | 55 / 150 / 56 |      |

1) For package mounted on aluminium 15 mm x 16.7 mm x 0.7 mm

**Electrical Characteristics, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified**

| Parameter | Symbol | Values |      |      | Unit |
|-----------|--------|--------|------|------|------|
|           |        | min.   | typ. | max. |      |

**Static Characteristics**

|   |               |     |     |    |    |
|---|---------------|-----|-----|----|----|
| Drain- source breakdown voltage<br>$V_{GS} = 0\text{ V}, I_D = 0.25\text{ mA}, T_j = 25^\circ\text{C}$  | $V_{(BR)DSS}$ | 100 | -   | -  | V  |
| Gate threshold voltage<br>$V_{GS} = V_{DS}, I_D = 1\text{ mA}$  | $V_{GS(th)}$  | 0.8 | 1.5 | 2  |    |
| Zero gate voltage drain current<br>$V_{DS} = 100\text{ V}, V_{GS} = 0\text{ V}, T_j = 25^\circ\text{C}$ | $I_{DSS}$     | -   | 0.1 | 1  | μA |
| $V_{DS} = 100\text{ V}, V_{GS} = 0\text{ V}, T_j = 125^\circ\text{C}$                                   |               | -   | 2   | 60 |    |
| $V_{DS} = 20\text{ V}, V_{GS} = 0\text{ V}, T_j = 25^\circ\text{C}$                                     |               | -   | -   | 10 | nA |
| Gate-source leakage current<br>$V_{GS} = 20\text{ V}, V_{DS} = 0\text{ V}$                              | $I_{GSS}$     | -   | 10  | 50 | nA |
| Drain-Source on-state resistance<br>$V_{GS} = 10\text{ V}, I_D = 0.17\text{ A}$                         | $R_{DS(on)}$  | -   | 3   | 6  | Ω  |
| $V_{GS} = 4.5\text{ V}, I_D = 0.17\text{ A}$  |               | -   | 4.5 | 10 |    |

**Electrical Characteristics**, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

| Parameter | Symbol | Values |      |      | Unit |
|-----------|--------|--------|------|------|------|
|           |        | min.   | typ. | max. |      |

**Dynamic Characteristics**

|   |              |      |     |    |    |
|---|--------------|------|-----|----|----|
| Transconductance<br>$V_{DS} \geq 2 * I_D * R_{DS(on)max}$ , $I_D = 0.17\text{ A}$                                       | $g_{fs}$     | 0.08 | 0.2 | -  | S  |
| Input capacitance<br>$V_{GS} = 0\text{ V}$ , $V_{DS} = 25\text{ V}$ , $f = 1\text{ MHz}$                                | $C_{iss}$    | -    | 65  | 85 | pF |
| Output capacitance<br>$V_{GS} = 0\text{ V}$ , $V_{DS} = 25\text{ V}$ , $f = 1\text{ MHz}$                               | $C_{oss}$    | -    | 10  | 15 |    |
| Reverse transfer capacitance<br>$V_{GS} = 0\text{ V}$ , $V_{DS} = 25\text{ V}$ , $f = 1\text{ MHz}$                     | $C_{rss}$    | -    | 4   | 6  |    |
| Turn-on delay time<br>$V_{DD} = 30\text{ V}$ , $V_{GS} = 10\text{ V}$ , $I_D = 0.28\text{ A}$<br>$R_{GS} = 50\ \Omega$  | $t_{d(on)}$  | -    | 5   | 8  | ns |
| Rise time<br>$V_{DD} = 30\text{ V}$ , $V_{GS} = 10\text{ V}$ , $I_D = 0.28\text{ A}$<br>$R_{GS} = 50\ \Omega$           | $t_r$        | -    | 5   | 8  |    |
| Turn-off delay time<br>$V_{DD} = 30\text{ V}$ , $V_{GS} = 10\text{ V}$ , $I_D = 0.28\text{ A}$<br>$R_{GS} = 50\ \Omega$ | $t_{d(off)}$ | -    | 10  | 13 |    |
| Fall time<br>$V_{DD} = 30\text{ V}$ , $V_{GS} = 10\text{ V}$ , $I_D = 0.28\text{ A}$<br>$R_{GS} = 50\ \Omega$           | $t_f$        | -    | 12  | 16 |    |

**Electrical Characteristics**, at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

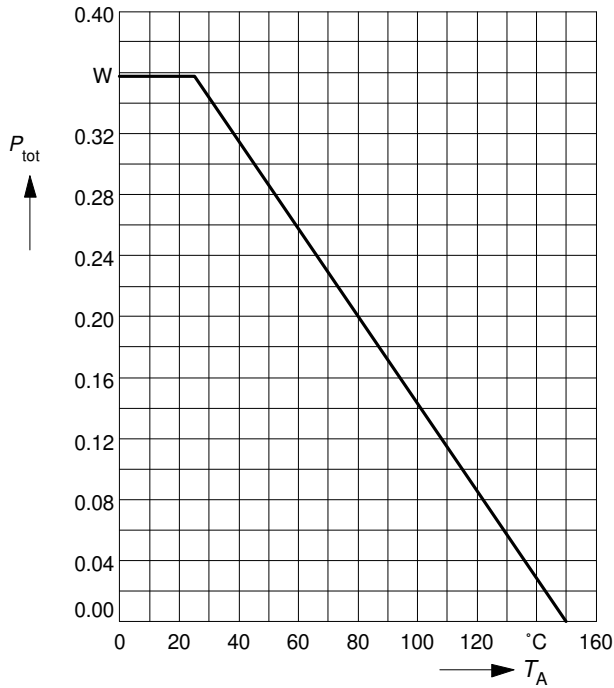
| Parameter | Symbol | Values |      |      | Unit |
|-----------|--------|--------|------|------|------|
|           |        | min.   | typ. | max. |      |

**Reverse Diode**

|   |          |   |      |      |   |
|---|----------|---|------|------|---|
| Inverse diode continuous forward current<br>$T_A = 25^\circ\text{C}$                                | $I_S$    | - | -    | 0.17 | A |
| Inverse diode direct current,pulsed<br>$T_A = 25^\circ\text{C}$                                     | $I_{SM}$ | - | -    | 0.68 |   |
| Inverse diode forward voltage<br>$V_{GS} = 0\text{ V}, I_F = 0.34\text{ A}, T_j = 25^\circ\text{C}$ | $V_{SD}$ | - | 0.85 | 1.3  | V |

**Power dissipation**

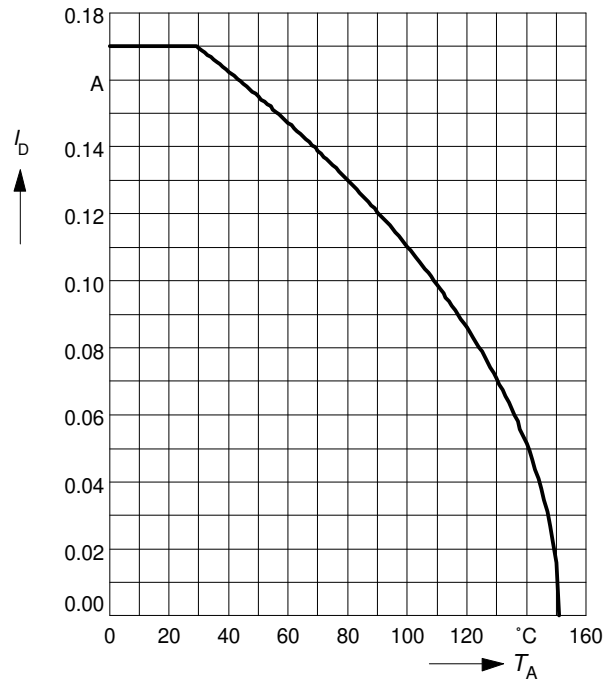
$$P_{\text{tot}} = f(T_A)$$



**Drain current**

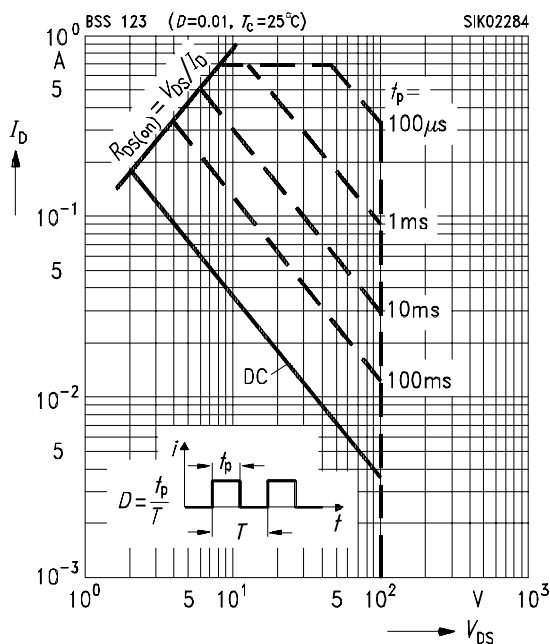
$$I_D = f(T_A)$$

parameter:  $V_{GS} \geq 10 \text{ V}$



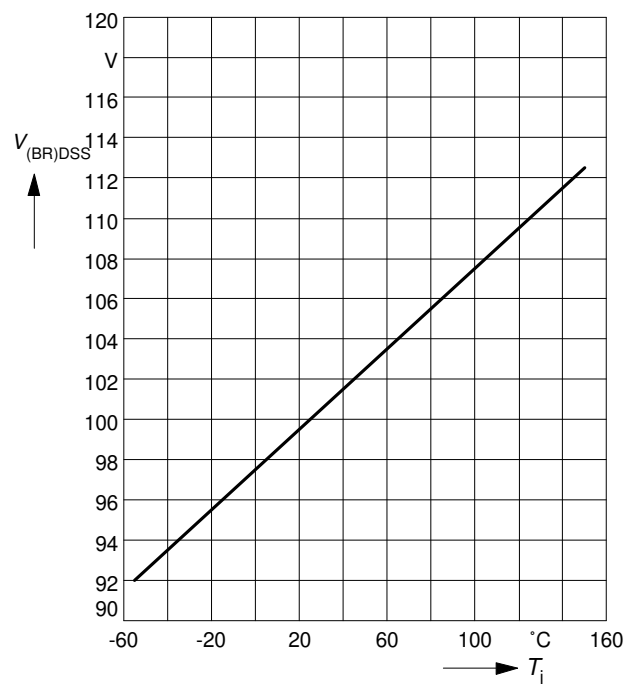
**Safe operating area  $I_D = f(V_{DS})$**

parameter :  $D = 0.01, T_C = 25^\circ\text{C}$



**Drain-source breakdown voltage**

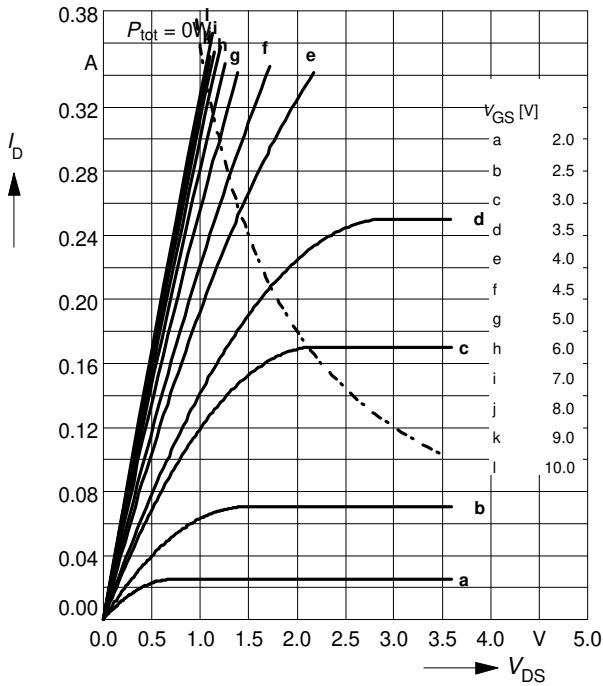
$$V_{(BR)DSS} = f(T_j)$$



**Typ. output characteristics**

$$I_D = f(V_{DS})$$

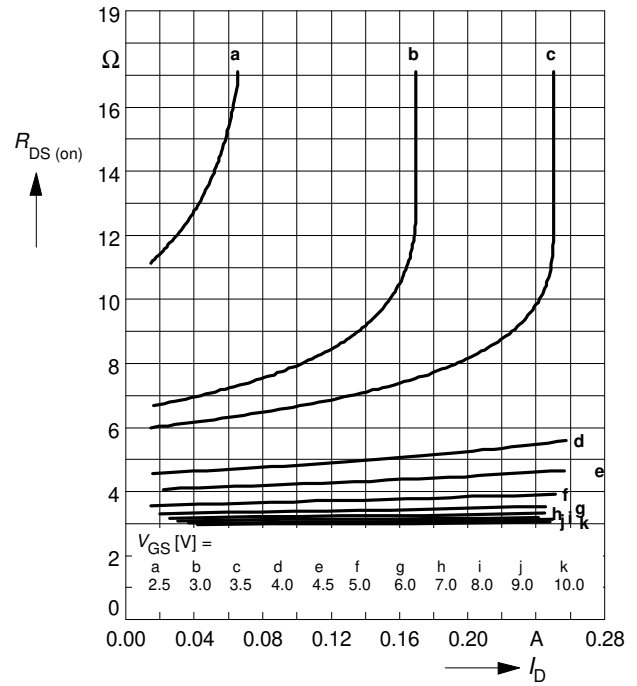
parameter:  $t_p = 80 \mu s$ ,  $T_j = 25^\circ C$



**Typ. drain-source on-resistance**

$$R_{DS(on)} = f(I_D)$$

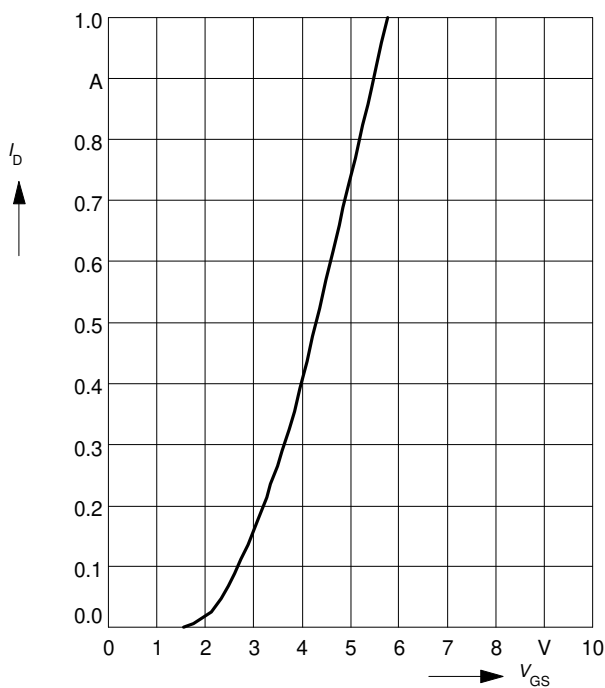
parameter:  $t_p = 80 \mu s$ ,  $T_j = 25^\circ C$



**Typ. transfer characteristics**  $I_D = f(V_{GS})$

parameter:  $t_p = 80 \mu s$

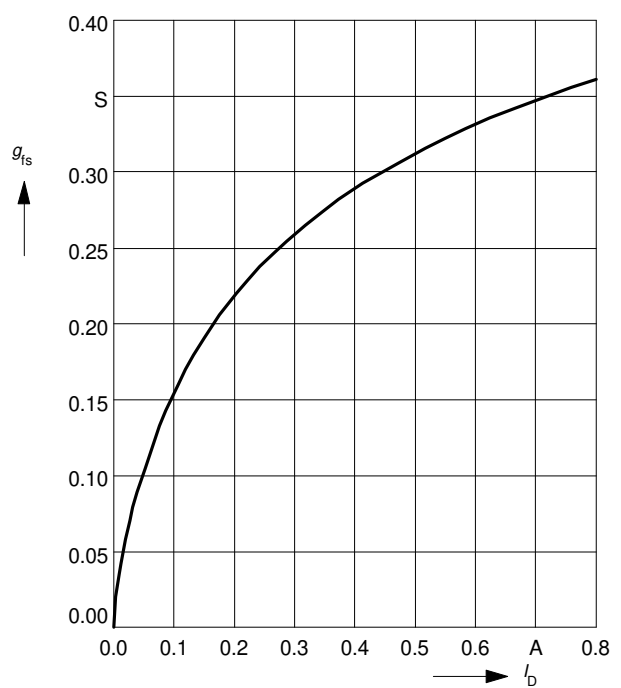
$$V_{DS} \geq 2 \times I_D \times R_{DS(on)max}$$



**Typ. forward transconductance**  $g_{fs} = f(I_D)$

parameter:  $t_p = 80 \mu s$ ,

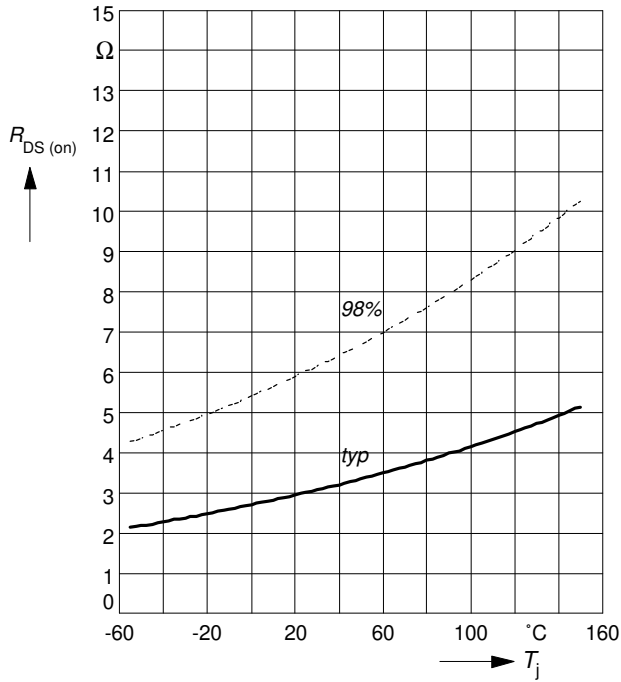
$$V_{DS} \geq 2 \times I_D \times R_{DS(on)max}$$



**Drain-source on-resistance**

$$R_{DS(on)} = f(T_j)$$

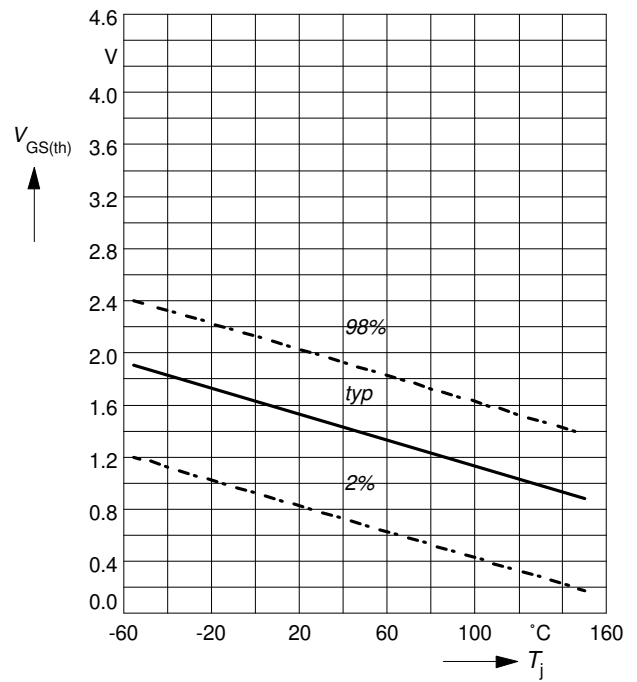
parameter:  $I_D = 0.17\text{ A}$ ,  $V_{GS} = 10\text{ V}$



**Gate threshold voltage**

$$V_{GS(th)} = f(T_j)$$

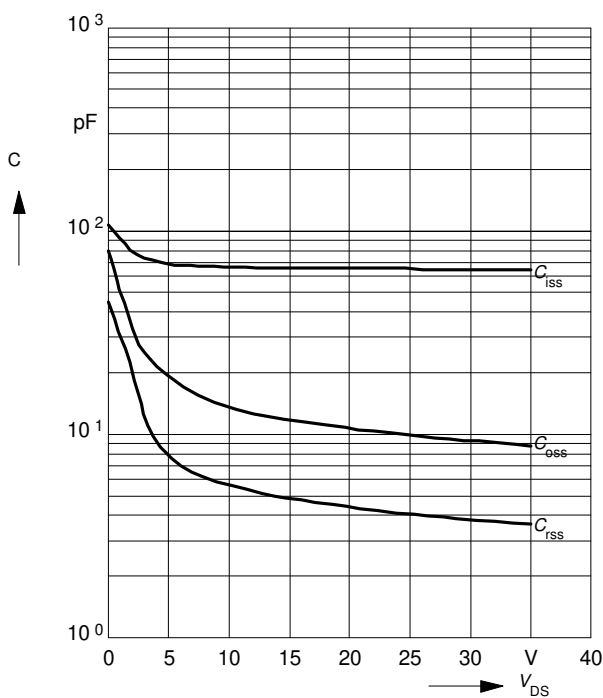
parameter:  $V_{GS} = V_{DS}$ ,  $I_D = 1\text{ mA}$



**Typ. capacitances**

$$C = f(V_{DS})$$

parameter:  $V_{GS} = 0\text{ V}$ ,  $f = 1\text{ MHz}$



**Forward characteristics of reverse diode**

$$I_F = f(V_{SD})$$

parameter:  $T_j, t_p = 80\text{ }\mu\text{s}$

